

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/956,910 HARTWIG ET AL.	
		Examiner	Art Unit	Page 1 of 1 Annan Q. Shang

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,259,891	07-2001	Allen, James D.	455/3.02
*	C	US-5,565,909	10-1996	Thibadeau et al.	725/35
*	D	US-5,850,444	12-1998	Rune, Johan	705/79
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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